



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inter Patent Application of

Joji Nii et al.

Application No.: 10/003,404

Filed: December 6, 2001

For: SEMICONDUCTOR DEVICE WITH
IMPROVED SOFT ERROR
RESISTANCE

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) Group Art Unit: 2826

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) Examiner: TAN N. TRAN

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) Confirmation No.: 5384
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)
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SUBMISSION OF PRIOR ART UNDER 37 C.F.R. §1.501

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure as set forth in 37 C.F.R. §1.56, Applicants hereby submit the following information cited in a corresponding Korean Office Action dated September 24, 2004, in conformance with 37 C.F.R. §§1.97 and 1.98. Pursuant to 37 C.F.R. §1.98, a copy of the document cited is enclosed.

To assist the Examiner, the documents are listed on the attached form PTO-1449. It is respectfully requested that an Examiner initialed copy of this form be returned to the undersigned.

Respectfully submitted,

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Date: November 4, 2004

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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Complete if Known

Sheet			1	of	1	Application Number	10/003,404
						Filing Date	December 6, 2001
						First Named Inventor	Koji Nii et al.
						Examiner Name	TAN N TRAN
						Attorney Docket Number	027260-505

U.S. PATENT DOCUMENTS

Examiner Initials	Document Number	Kind Code (if known)	Name of Patentee or Applicant of Cited Document	Issue/Publication Date (MM-DD-YYYY)
	5,912,188		Gardner et al.	06-15-1999

FOREIGN PATENT DOCUMENTS

Examiner Initials	Document Number	Kind Code (if known)	Country	Date of Publication (MM-DD-YYYY)	STATUS						
					Translation	Partial Translation	Eng. Lang. Summary	Search Report	IPER	Abstract	Cited in Spec

NON-PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS); title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

Examiner Signature

Date Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.